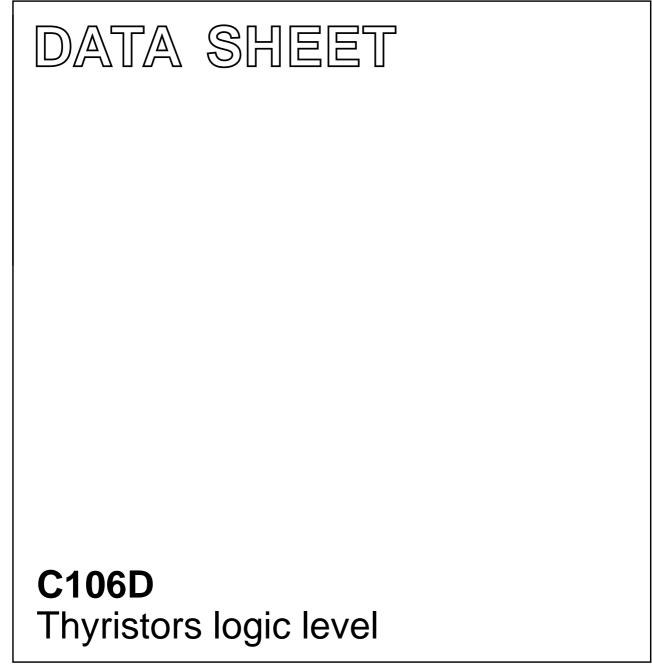
DISCRETE SEMICONDUCTORS



Product specification

July 2001



C106D

GENERAL DESCRIPTION

Passivated, sensitive gate thyristor in a plastic envelope, intended for use in general purpose switching and phase control applications. This device is intended to be interfaced directly to microcontrollers, logic integrated circuits and other low power gate trigger circuits.

QUICK REFERENCE DATA

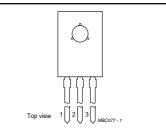
SYMBOL	PARAMETER	MAX.	UNIT
$\begin{array}{l} V_{DRM} \\ V_{RRM} \\ I_{T(AV)} \\ I_{T(RMS)} \\ I_{TSM} \end{array}$	Repetitive peak off-state voltages Average on-state current RMS on-state current Non-repetitive peak on-state current	400 2.5 4 38	V A A A

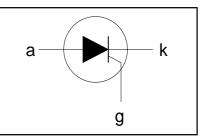
PINNING - SOT32

PIN CONFIGURATION

SYMBOL

PIN	DESCRIPTION	
1	cathode	
2	anode	
3	gate	





LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{drm}, V_{rrm}	Repetitive peak off-state voltages		-	400 ¹	V
I _{T(AV)} I _{T(RMS)} I _{TSM}	Average on-state current RMS on-state current Non-repetitive peak on-state current	half sine wave; $T_{mb} \le 113$ °C all conduction angles half sine wave; $T_j = 25$ °C prior to surge	-	2.5 4	A A
l²t dl _⊤ /dt	I ² t for fusing Repetitive rate of rise of	t = 10 ms t = 8.3 ms t = 10 ms $I_{TM} = 10 A; I_G = 50 mA;$	- - -	35 38 6.1 50	Α Α Α ² s Α/μs
$\begin{array}{l} I_{GM} \\ V_{GM} \\ P_{RGM} \\ P_{GM} \\ P_{G(AV)} \\ T_{stg} \\ T_{j} \end{array}$	on-state current after triggering Peak gate current Peak gate voltage Peak reverse gate voltage Peak gate power Average gate power Storage temperature Operating junction temperature	$dI_G^{\circ}/dt = 50 \text{ mA}/\mu \text{s}$ over any 20 ms period	- - - -40 -	2 5 5 0.5 150 125 ²	°°°° °°°× A ∧ ∧ N S N S N

¹ Although not recommended, off-state voltages up to 800V may be applied without damage, but the thyristor may switch to the on-state. The rate of rise of current should not exceed 15 $A/\mu s$.

² Note: Operation above 110°C may require the use of a gate to cathode resistor of $1k\Omega$ or less.

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THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
R _{th j-mb}	Thermal resistance		-	-	2.5	K/W
R _{th j-a}	junction to mounting base Thermal resistance junction to ambient	in free air	-	-	95	K/W

STATIC CHARACTERISTICS

 $T_i = 25$ °C unless otherwise stated

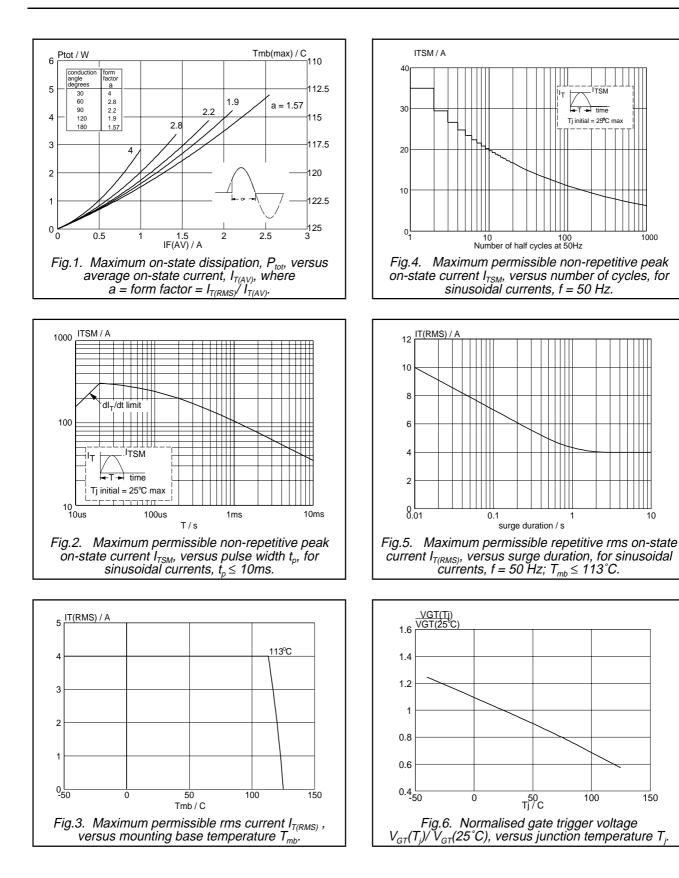
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I _{GT}	Gate trigger current	$V_{\rm D} = 12 \text{ V}; \text{ I}_{\rm T} = 0.1 \text{ A}$	-	15	200	μA
	Latching current	$V_{\rm D} = 12 \text{ V}; I_{\rm GT} = 0.1 \text{ A}$	-	0.17	10	mΑ
	Holding current	$V_{\rm D} = 12 \text{ V}; I_{\rm GT} = 0.1 \text{ A}$	-	0.10	6	mA
İΫ _τ	On-state voltage	$I_{T} = 5 A$	-	1.23	1.8	V
V _{GT}	Gate trigger voltage	$\dot{V}_{\rm D} = 12 \text{ V}; \text{ I}_{\rm T} = 0.1 \text{ A}$	-	0.4	1.5	V
		$V_{\rm D} = V_{\rm DRM(max)}$; $I_{\rm T} = 0.1$ A; $T_{\rm j} = 110$ °C	0.1	0.2	-	V
I _D , I _R	Off-state leakage current	$V_D = V_{DRM(max)}^{ORM(max)}; V_R = V_{RRM(max)}; T_j = 125 \degree C$	-	0.1	0.5	mA

DYNAMIC CHARACTERISTICS

 $T_j = 25$ °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
dV _D /dt	Critical rate of rise of off-state voltage	V_{DM} = 67% $V_{DRM(max)}$; T _j = 125 °C; exponential waveform; R _{GK} = 100 Ω	-	50	-	V/µs
t _{gt}	Gate controlled turn-on	$I_{TM} = 10 \text{ A}; V_D = V_{DRM(max)}; I_G = 5 \text{ mA};$ $dI_C/dt = 0.2 \text{ A/us}$	-	2	-	μs
t _q	Circuit commutated turn-off time		-	100	-	μs

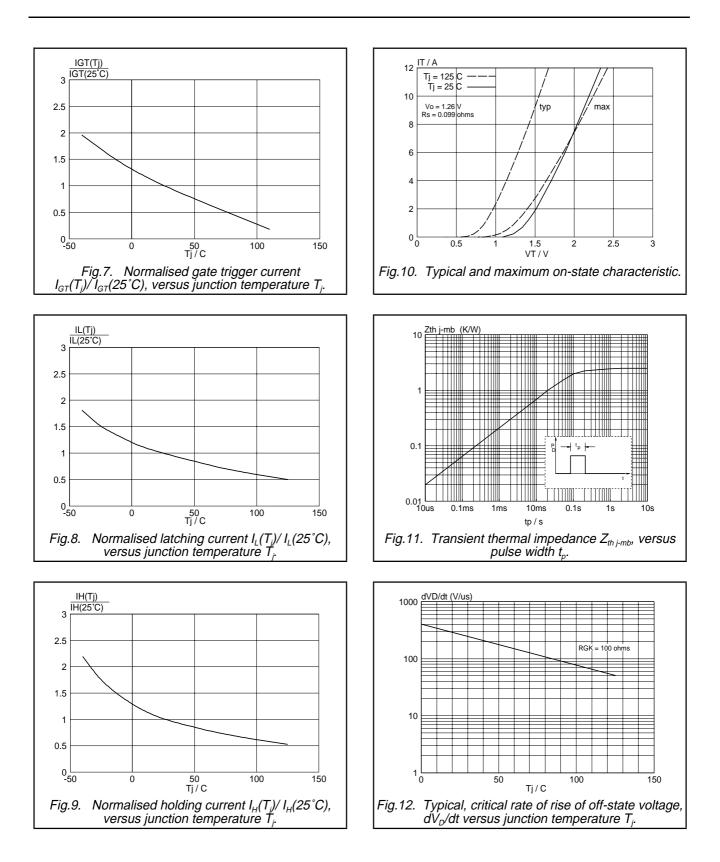
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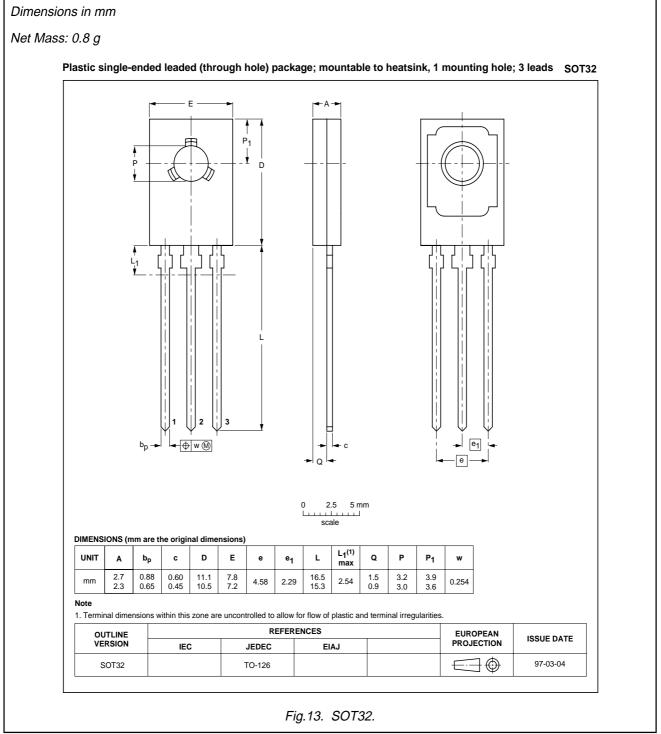
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MECHANICAL DATA



Notes

Refer to mounting instructions for SOT32 envelopes.
Epoxy meets UL94 V0 at 1/8".

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DEFINITIONS

DATA SHEET STATUS					
DATA SHEET STATUS ³	PRODUCT STATUS⁴	DEFINITIONS			
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice			
Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in ordere to improve the design and supply the best possible product			
Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Changes will be communicated according to the Customer Product/Process Change Notification (CPCN) procedure SNW-SQ-650A			
Limiting values					
Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of					

operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

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³ Please consult the most recently issued datasheet before initiating or completing a design.

⁴ The product status of the device(s) described in this datasheet may have changed since this datasheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.

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